

Chandra X-Ray Data Analysis Overview

$$S_D(\sigma, h, t) = T(\sigma, t) \int d\lambda \int d\hat{p} R(\sigma, h, \lambda, \theta(\hat{p}), t) S(\lambda, \hat{p})$$

counts Good-Time
Dead-Time Response: Truth

$\sigma \equiv$ detected position
 $h \equiv$ detected "wavelength"
 $t \equiv$ time
 $\lambda \equiv$ incident wavelength
 $\hat{p} \equiv$ incident angle

Mirror area
Mirror PSF
Grating effic
Grating LSF
Detector effic
Detector redistribution
Aspect
Coordinate systems

\therefore The 3 most important
things are:

1. CALIBRATION

2. CALIBRATION

3. CALIBRATION

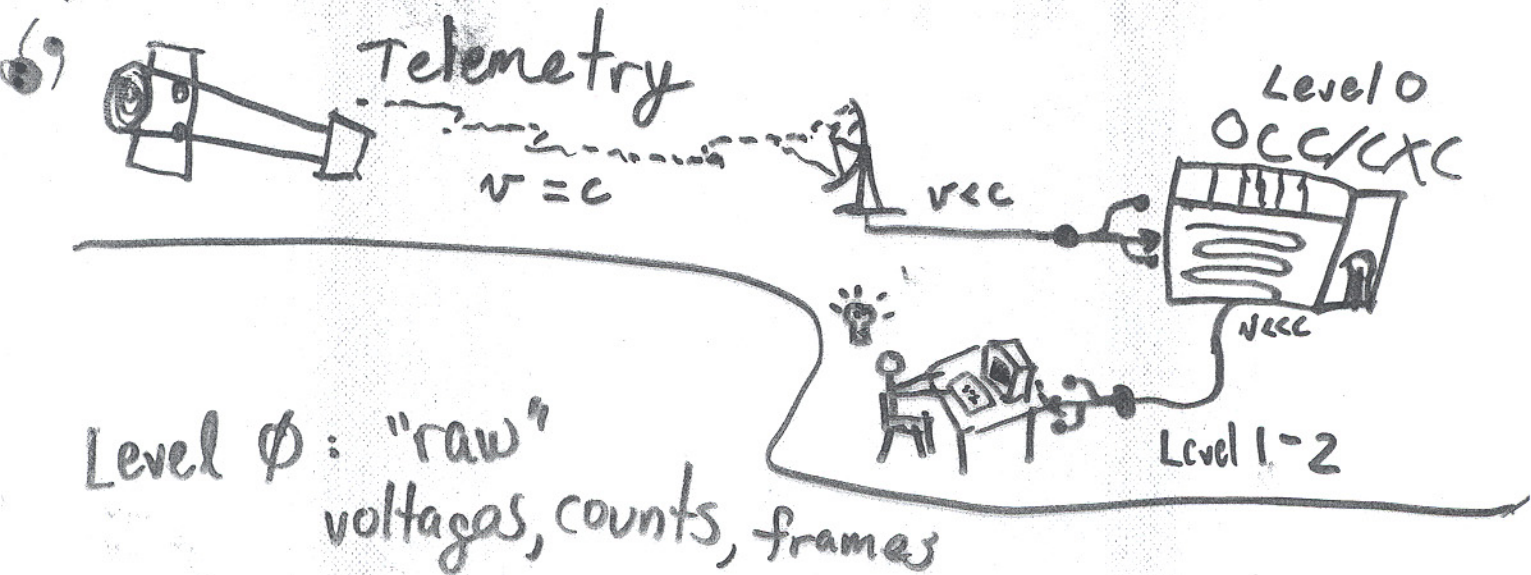
The rest is

- software
+ organization



ANALYSIS

Data Products



Level 1: scaled, calibrated, aspect-corrected
ENERGY = $f(\text{chip, gain})$

Level 1.5 (a.k.a. "1a"): source dependent coords.
(grating) detect, src
diffraction corr

Level 2 - filtered, concatenated, binned
good grades
good pixels
good aspect...

User Level 2: binning, modeling
images src models
spectra fits
light-curves
responses

ANALYSIS - Preparation

where to start?

Know your data!

"OIF" = Observation
Index

evt2.fits - filtered
event list (+ GTI)

pha2 - (if grating) binned counts spectra
(+ REGION)

Check your data:

vv.obsid

Display, e.g.

sky x, y vs order, r
det x, y

pha vs time

counts vs channel
vs wavelength

Check cal files -

ASCDSVER

CALDBVER

vs info on web or chandra-us

Reprocess?

evt1

evt1a

asof

aoff

lviv

acis-process-events

hrc- " "

dmcopy

tgdetect

tg-create-mask

tg-resolve-events

tgextract

2001.01.24 DPH

Analysis - Planning

SPATIAL

(dncopy)



point src
extended src

Images: (dncopy)

ACIS-I, S3, HRC-I

SPECTRAL

(dncopy)



low-res
high-res

"pha": (dmextract)
(tgextract)

ACIS-I, S3

HETGS, LETGS

TEMPORAL

low-res
high-res

Light Curves: (lightcurve)

ACIS, HRC

ACIS-CC, HRC-S

RESPONSES

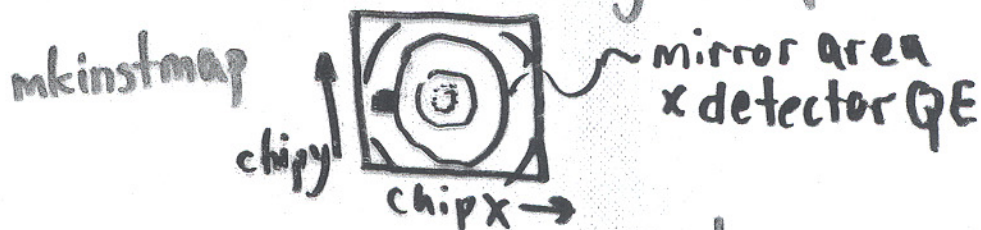
RESPONSES

Spatial: Exposure^{*} Map
 * [area * time]

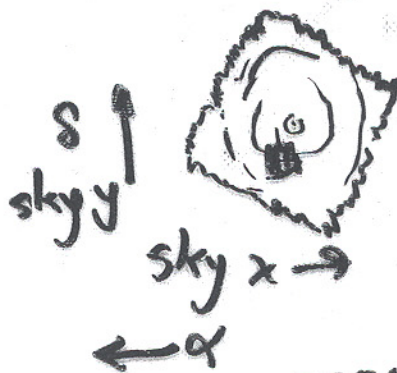
- keeps spatial information
 at the expense of spectral

$$\int_{\lambda_{\text{min}}}^{\lambda_{\text{max}}} S_{\lambda}(\lambda, \beta) \approx \frac{C(\Delta h, \beta)}{E(\Delta h, \lambda, \beta)}$$

Instrument map → all calibration info
 band-integrated



Exposure map → • applies aspect
 (via aspect histogram)
 • applies coordinate xform



Responses

Spectral - Low Resolution

- keeps spectral information at the expense of spatial

$$C_{\Omega}(h) = \tau_{\text{eff}} \int_{\Omega} d\lambda D_R(h, \lambda) A_{\Omega}(\lambda, \hat{q})^* S(\lambda)$$

* point source, at location \hat{q} , in region Ω .

$D_R(h, \lambda)^{**}$ = Redistribution Matrix Function
"RMF" [File]

$A_{\Omega}(\lambda, \hat{q})$ = Auxiliary Response Function
"ARF" [File]

≡ "effective" effective area

* mkarf: applies inverse aspect to map sky to detector vs time

** mkrmf: computes/looks up vs chip + position